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Application Specific Discretes A.S.D.™

PROGRAMMABLE TRANSIENT VOLTAGE SUPPRESSOR FOR SLIC PROTECTION

FEATURES

- DUAL PROGRAMMABLE TRANSIENT SUP-PRESSOR.
- WIDE NEGATIVE FIRING VOLTAGE RANGE : $V_{MGL} = -80V$ max.
- LOW DYNAMIC SWITCHING VOLTAGES : $V_{\mbox{\scriptsize FP}}$ and $V_{\mbox{\scriptsize DGL}}.$
- LOW GATE TRIGGERING CURRENT : $I_{GT} = 5mA max$.
- PEAK PULSE CURRENT : I_{PP} = 30A for 10/1000μs surge.
- HOLDING CURRENT : I_H = 150mA.

DESCRIPTION

This device has been especially designed to protect subscriber line card interfaces (SLIC) against transient overvoltages.

Positive overloads are clipped with 2 diodes. Negative surges are suppressed by 2 thyristors, their breakdown voltage being referenced to

-V_{BAT} through the gate.

This component presents a very low gate trigge-ring current (I_{GT}) in order to reduce the current consumption on printed circuit board during the firing phase.

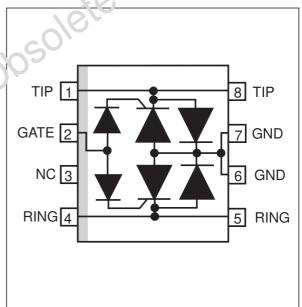
A particular attention has been given to the internal wire bonding. The "4-point" configuration ensures reliable protection, eliminating the overvoltage introduced by the parasitic indictances of the wiring (Ldi/dt), especially for very fast transients.

COMPLIES WITH THE FOLLOWING STANDARDS

CCITT K20 ·	10/700μs 5/310μs	1kV 25A
VDF_ 0.133 :	10/700μs 5/310μs	2kV 38A (*)
: 0878 EU	1.2/50μs 1/20μs	1.5kV 40A
13124 :	0.5/700μs 0.2/310μs	1kV 25A
FCC part 68 :	2/10μs 2/10μs	2.5kV 170A (*)
BELLCORE		
TR-NWT-001089 :	•	2.5kV
	2/10µs	170A (*)
(*) with series resist	tors or PTC.	

SO-8

SCHEMATIC D!^GFAM



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October 2003 - Ed: 4

ABSOLUTE MAXIMUM RATINGS (Tamb = 25 °C)

Symbol	Parameter		Value	Unit	
I _{PP}	Peak pulse current (see note 1)				
I _{TSM}	Non repetitive surge peak on-state current $(F = 50Hz)$	8 3.5	A		
I _{GSM}	Maximum gate current (half sine wave tp = 10r	ns)	2	Α	
V _{MLG} V _{MGL}	Maximum voltage LINE / GROUND Maximum voltage GATE / LINE		-100 -80	V	
T _{stg} Tj	Storage temperature range Maximum junction temperature	- 55 to + 150 150	°C		
TL	Maximum lead temperature for soldering during	g 10s	260	°C	

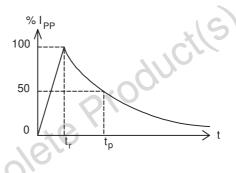
Note 1 : Pulse waveform :

10/1000µs tr=10μs 5/310µs 2/10µs

tr=5µs

t_r=2µs

tp=1000μs tp=310μs . tp=10μs

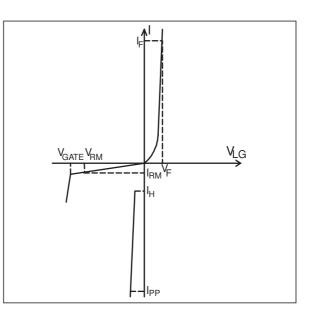


THERMAL RESISTANCE

Symbol		Parameter	Value	Unit
R _{th (j-a)}	Junction to ambient		170	°C/W

ELECTRICAL CHARACTERISTICS (T_{amb} = 25°C)

Symbol	Parameter
I _{GT}	Gate triggering current
Iн	Holding current
I _{RM}	Reverse leakage current LINE/GND
IRG	Reverse leakage current GATE/LINE
V _{RM}	Reverse voltage LINE/GND
VF	Forward drop voltage LINE/GND
V _{GT}	Gate triggering voltage
V _{FP}	Peak forward voltage LINE/GND
V _{DGL}	Dynamic switching voltage GATE/LINE
V _{GATE}	GATE/GND voltage
V _{LG}	LINE/GND voltage
С	Off-state capacitance LINE/GND



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Symbol		Т	est condition	Maximum	Unit	
VF	I _F =5A	t _p =500µs			3	V
V _{FP}	10/700μs 1.2/50μs 2/10μs	1.5kV 1.5kV 2.5kV	R _p =10Ω R _p =10Ω R _p =62Ω	(see note 1)	5 7 12	V

1 - PARAMETERS RELATED TO THE DIODE LINE/GND (Tamb = 25 °C)

Note 1 : See test circuit 2 for V_{FP} ; R_p is the protection resistor located on the line card.

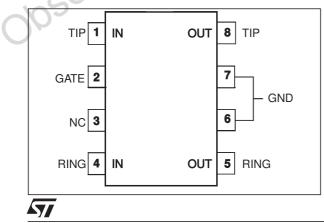
2 - PARAMETERS RELATED TO THE PROTECTION THYRISTOR ($T_{amb} = 25^{\circ}C$)

Sym- bol	Test conditions	Min.	Max.	Unit					
I _{GT}	$V_{GND/LINE} = -48V$	0.2	5	mA					
Ін	V _{GATE} =-48V (see note 2)	150		mA					
V _{GT}	at I _{GT}		2.5	Cν					
I _{RG}	$T_c=25^{\circ}C$ $V_{RG} = -75V$ $T_c=70^{\circ}C$ $V_{RG} = -75V$		5 50	μA					
V _{DGL}	VGATE= -48V (see note 3) 10/700μs 1.5kV Rp=10Ω I _{PP} =30A 1.2/50μs 1.5kV Rp=10Ω I _{PP} =30A 2/10μs 2.5kV Rp=62Ω I _{PP} =38A	PIC	10 20 25	V					
Z/10µS Z.5KV Np=6252 Ipp=36A Z5 Note 2 : See the functional holding current (I _H) test circuit 2. See the functional holding current (I _H) test circuit 2.									

3 - PARAMETERS RELATED TO DIODE AND PROTECTION THYRISTOR (Tamb = 25 °C)

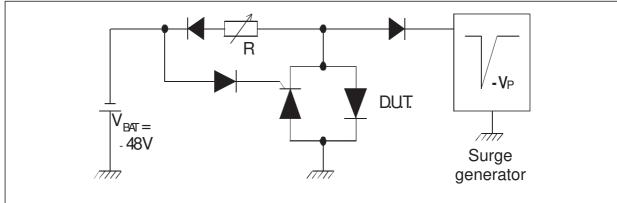
Sym- bol	Test conditions	Maximum	Unit
I _{RM}	$\begin{array}{ll} T_c=25^\circ C & V_{GATE/LINE}=-1V & V_{RM}=-75V \\ T_c=70^\circ C & V_{GATE/LINE}=-1V & V_{RM}=-75V \end{array}$	5 50	μA

APPLICATION NOTE



In order to take advantage of the "4 point" structure of the LCP, the TIP and RING lines go across the device. In such case, the device will eliminate the overvoltages generated by the parasitic inductances of the wiring (Ldi/dt), especially for very fast transients.

FUNCTIONAL HOLDING CURRENT (I_H) TEST CIRCUIT 1 : GO-NO GO TEST

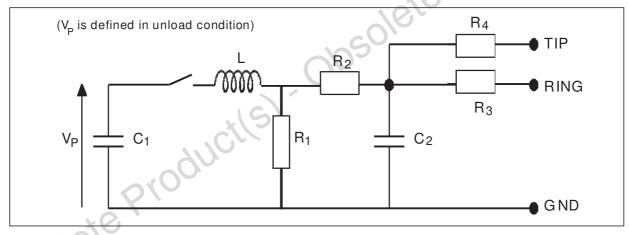


This is a GO-NO GO test which allows to confirm the holding current (I_H) level in a functional test circuit.

TEST PROCEDURE :

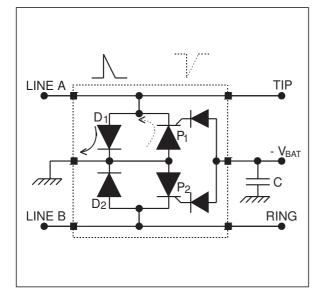
- Adjust the current level at the I_H value by short circuiting the D.U.T. Fire the D.U.T. with a surge current : I_{PP} = 10A, 10/1000µs.
- The D.U.T. will come back to the off-state within a duration of 50ms max.

TEST CIRCUIT 2 FOR V_{FP} AND V_{DGL} PARAMETERS



	Pulse	e (μs)	Vp	C ₁	C ₂	L	R ₁	R ₂	R 3	R 4	I _{PP}	Rp
\cup	tr	tp	(V)	(μF)	(nF)	(μΗ)	(Ω)	(Ω)	(Ω)	(Ω)	(A)	(Ω)
	10	700	1500	20	200	0	50	15	25	25	30	10
	1.2	50	1500	1	33	0	76	13	25	25	30	10
	2	10	2500	10	0	1.1	1.3	0	3	3	38	62

FUNCTIONAL DESCRIPTION



Surge peak current versus overload duration.

ITSM(A) 10 F=50Hz Tj initial=25°C 9 8 7 6 5 4 3 2 +++ 1 t(s) -----obsolete Produk 0 L 1E-2 1E+2 1E+3

LINE A PROTECTION :

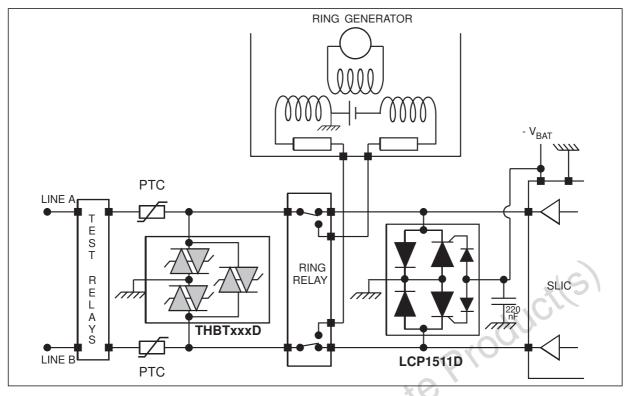
- For positive surges versus GND, the diode D1 will conduct.
- For negative surges versus GND, the protection device P1 will trigger at a voltage fixed by the -V_{BAT} reference.

LINE B PROTECTION :

 For surges on line B, the operating mode is the same, D2 or P2 is activated.

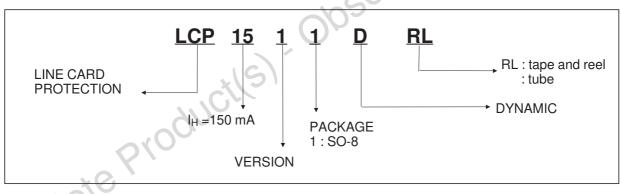
It is recommended to add a capacitor (C=220nF) close to the gate of the LCP, in order to speed up the triggering.

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APPLICATION CIRCUIT : typical SLIC protection concept

ORDER CODE

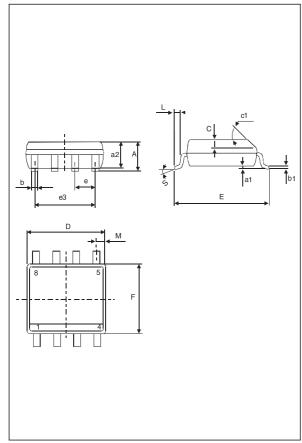


MARKING

Package	Туре	Marking
SO-8	LCP1511D	CP151D

PACKAGE MECHANICAL DATA

SO-8 Plastic



	DIMENSIONS								
REF.	Mi	illimetr	es	Inches					
	Min.	Тур.	Max.	Min.	Тур.	Max.			
А			1.75			0.069			
a1	0.1		0.25	0.004		0.010			
a2			1.65			0.065			
b	0.35		0.48	0.014		0.019			
b1	0.19		0.25	0.007		0.010			
С		0.50			0.020				
c1			45°	(typ)					
D	4.8		5.0	0.189		0.197			
Е	5.8		6.2	0.228		0.244			
е		1.27			0.050				
e3		3.81			0.150				
F	3.8		4.0	0.15	5	0.157			
L	0.4		1.27	0.016		0.050			
М			0.6			0.024			
S		0.	8° (r	max)					
osoleito									

Weight = 0.08 g.

Packaging : Product supplied in antistatic tubes or tape and reel .

P10

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